

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>	
	10/705,915	JEON ET AL.	
	<b>Examiner</b> James J. Debrow	<b>Art Unit</b> 2176	

**SEARCHED**

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner